

Notice of References Cited	Application/Control No. 10/084,019		Applicant(s)/Patent Under Reexamination TIEDEMANN ET AL.	
	Examiner VENKATESH HALIYUR		Art Unit 2619	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,905,742	05-1999	Chennakeshu et al.	714/792
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*	C	US-2003/0072395	04-2003	Jia et al.	375/341
*	D	US-6,535,497	03-2003	Raith, Alex Krister	370/336
*	E	US-5,960,039	09-1999	Martin et al.	375/267
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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